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## ML group earns fourth 'Star Team Award'

*by Pete Meltzer Jr., Materials and Manufacturing Directorate*

WRIGHT-PATTERSON AIR FORCE BASE, Ohio — A 20-member team of scientists and engineers at the Air Force Research Laboratory's Materials and Manufacturing Directorate received their fourth consecutive Air Force Office of Scientific Research "Star Team Award" for outstanding contributions to science, the Air Force and national defense.

The award recognizes teams of researchers who have demonstrated world-class status and excellence in their chosen research areas over a period of three years. The Characterization of Electronic Device Materials research team, headed by Dr. Cole Litton, a senior scientist in the Survivability and Sensor Materials Division, was recognized for in-house research focusing on the epitaxial growth and the optical, electrical and structural characterization of wide bandgap semiconductors. The team's combined efforts help advance the development of important systems that will directly benefit the warfighter and expand the range of commercial applications.

The Characterization of Electronic Device Materials research team is comprised of a group of professional government and contracted scientists and engineers. They include (government): Dr. Cole Litton (team leader), Edward Stutz, Jeff Brown, John Boeckl, Dr. Millard Mier, John Sizelove, Thomas Wille, Dr. Joseph Van Nostrand, James Ehret and Dr. Kent Averett; and (contractors): Dr. David Look (contract leader), Dr. Val Jogai, Dr. Z. Q. Fang, Dr. Bruce Claflin, Tim Cooper, Dr. Donald Reynolds, John Hoelscher, Wally Rice, Douglas McFarland and Dr. Gary Farlow. @